

Search Notes

Application/Control No.

10/648,367

Examiner

Khai M. Nguyen

Applicant(s)/Patent under
Reexamination

IIDA, TAKAYUKI

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
see	previous		KN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
see previous		KN